



MMIC DIE

Power Amplifier

PMA5-83-2W-D+

50Ω 0.01 to 10 GHz 2 W P_{SAT}

THE BIG DEAL

- P_{1dB}, Typ. +31 dBm
- P_{SAT}, Typ. +33 dBm
- Low Noise Figure, Typ. 3.5 dB
- High OIP₃, Typ. +43.5 dBm
- Supply Voltage +12 V, 400 mA

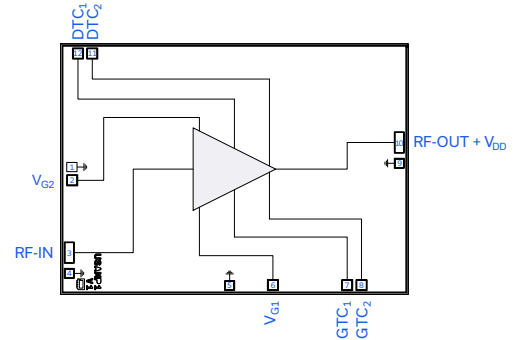
APPLICATIONS

- Test and Measurement Equipment
- Radar, EW, and ECM Defense Systems
- 5G Sub6, MIMO Wireless Infrastructure Systems
- Microwave Radio & VSAT

PRODUCT OVERVIEW

The PMA5-83-2W-D+ is a GaAs MMIC Distributed Power Amplifier operating from 0.01 to 10 GHz. The amplifier provides 12 dB of gain, +33 dBm saturated output power, and achieves +43.5 dBm output IP₃, while operating from a +12 V power supply and consuming 400 mA of current. In addition, the die is internally matched to 50 Ohms. These characteristics make it ideally suited for wideband test instrumentation and defense systems that require high operating output power, while maintaining very low distortion characteristics.

FUNCTIONAL DIAGRAM



SEE ORDERING INFORMATION ON THE LAST PAGE

KEY FEATURES

| Features | Advantages |
|--------------------------------------|---|
| High P _{1dB} Typ. +31 dBm | Flat gain and output power make this device excellent for wideband systems from 0.01 to 10 GHz that require at least 1 W of operating power over the full band. |
| High OIP ₃ Typ. +43.5 dBm | High operating OIP ₃ and low 2nd and 3rd harmonic response provides for very low in-band distortion products, which is typically needed for high fidelity measurement systems. |
| Low Noise Figure Typ. 3.5 dB | High operating output power accompanied with low noise figure enables a significant signal to noise ratio advantage for systems requiring high dynamic range. |
| Unpackaged Die | Suitable for chip and wire hybrid assemblies. |



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ELECTRICAL SPECIFICATIONS¹ AT +25°C, V_{DD} = +12 V, UNLESS NOTED OTHERWISE

| Parameter | Frequency (GHz) | Min. | Typ. | Max. | Units |
|---|-----------------|------|-------|------|-------|
| Frequency Range | | 0.05 | | 10 | GHz |
| Gain | 0.05 | | 18.0 | | dB |
| | 2 | | 13.2 | | |
| | 4 | | 13.1 | | |
| | 6 | | 13.0 | | |
| | 8 | | 12.6 | | |
| | 10 | | 12.0 | | |
| Output Power at 1 dB Compression (P1dB) | 0.5 | | +29.6 | | dBm |
| | 2 | | +31.0 | | |
| | 4 | | +31.6 | | |
| | 6 | | +31.3 | | |
| | 8 | | +30.9 | | |
| | 10 | | +30.7 | | |
| Output Power at 3 dB Compression (P3dB) | 0.5 | | +30.9 | | dBm |
| | 2 | | +32.5 | | |
| | 4 | | +33.3 | | |
| | 6 | | +33.3 | | |
| | 8 | | +33.3 | | |
| | 10 | | +32.8 | | |
| Output Power at Saturation (P _{SAT}) ² | 0.5 | | +31.9 | | dBm |
| | 2 | | +33.1 | | |
| | 4 | | +33.7 | | |
| | 6 | | +33.6 | | |
| | 8 | | +33.5 | | |
| | 10 | | +32.9 | | |
| Output Third-Order Intercept (P _{OUT} = +20 dBm/Tone) | 1 | | +46.0 | | dBm |
| | 2 | | +44.5 | | |
| | 4 | | +43.9 | | |
| | 6 | | +42.1 | | |
| | 8 | | +40.4 | | |
| | 10 | | +37.8 | | |
| Input Return Loss | 0.05 | | 20 | | dB |
| | 2 | | 12 | | |
| | 4 | | 20 | | |
| | 6 | | 20 | | |
| | 8 | | 15 | | |
| | 10 | | 17 | | |
| Output Return Loss | 0.05 | | 11 | | dB |
| | 2 | | 14 | | |
| | 4 | | 12 | | |
| | 6 | | 14 | | |
| | 8 | | 14 | | |
| | 10 | | 15 | | |





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ELECTRICAL SPECIFICATIONS¹ AT +25°C, V_{DD} = +12 V, UNLESS NOTED OTHERWISE (CONTINUED)

| Parameter | Frequency (GHz) | Min. | Typ. | Max. | Units |
|--|-----------------|------|------|-------|-------|
| Isolation | 0.05 | | 73 | | dB |
| | 2 | | 48 | | |
| | 4 | | 41 | | |
| | 6 | | 38 | | |
| | 8 | | 35 | | |
| | 10 | | 33 | | |
| Noise Figure ³ | 0.5 | | 6.8 | | dB |
| | 2 | | 3.7 | | |
| | 4 | | 2.8 | | |
| | 6 | | 2.9 | | |
| | 8 | | 3.3 | | |
| | 10 | | 4.1 | | |
| Device Operating Voltage (V _{DD}) | | | +12 | +16 | V |
| Device Operating Current (I _{DD}) ⁴ | | | 400 | | mA |
| Gate Voltage (V _{G1}) | | | -0.8 | | V |
| Gate Current (I _{G1}) | | | 15 | 4,000 | μA |
| Gate Voltage (V _{G2}) | | | +5 | | V |
| Gate Current (I _{G2}) | | | 15 | 4,000 | μA |
| DC Current Variation vs. Temperature ⁵ | | | 11 | | μA/°C |

1. Tested on Mini-Circuits Die Characterization Test Board. See Figure 2. De-embedded to the device reference plane.

2. P_{SAT} defined as when the Output Power changes 0.1 dB per 1 dB change in Input Power.

3. Noise Figure performance taken from packaged version of amplifier, PMA5-83-2W+.

4. Current at P_{IN} = -25 dBm. Increases to 650 mA at P1dB.

5. (Current at +85°C - Current at -45°C)/(130°C). VGS held constant over temperature.



MMIC DIE

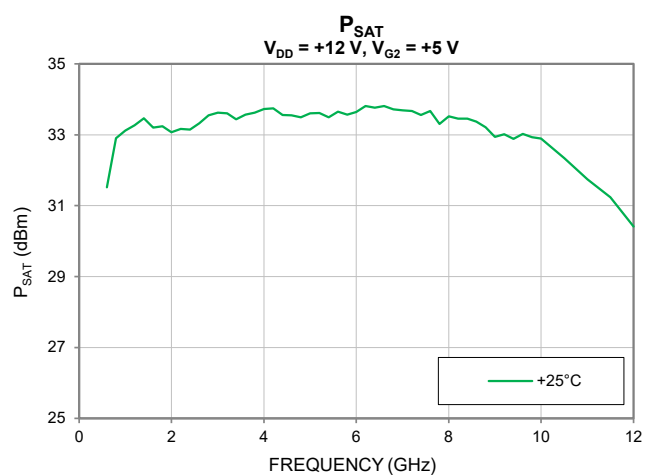
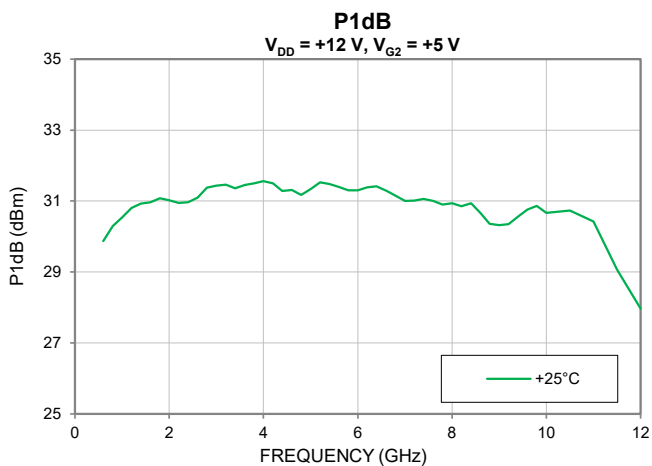
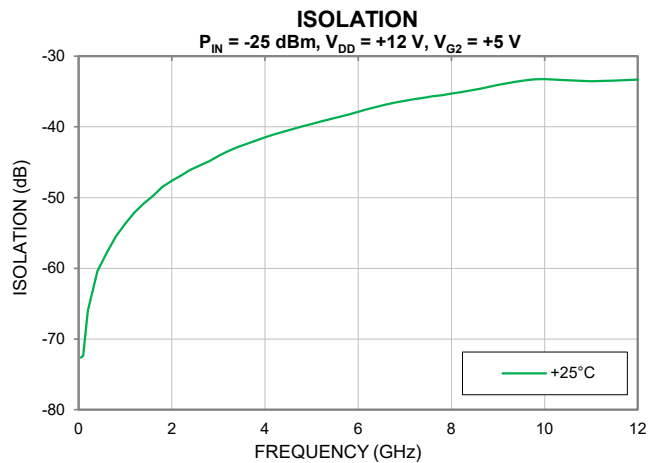
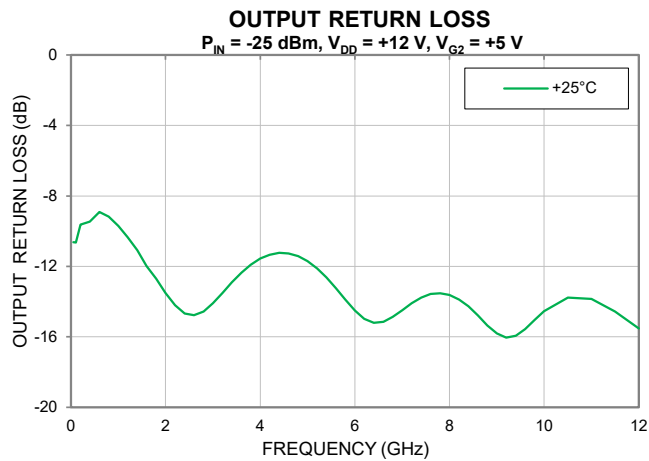
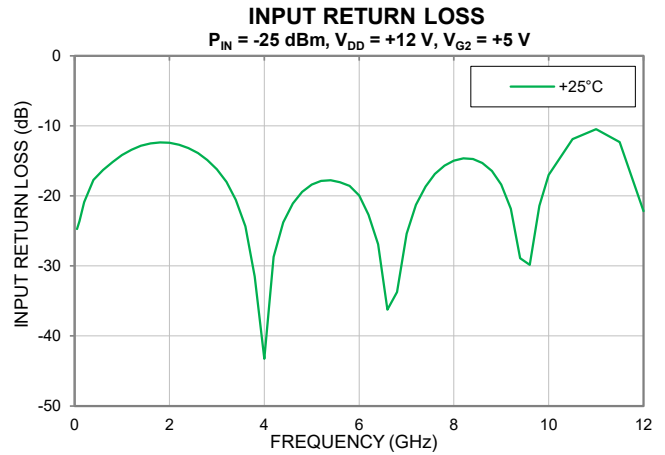
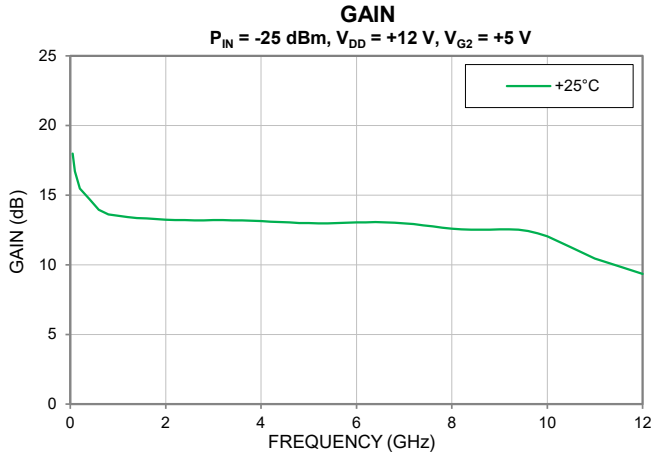
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TYPICAL PERFORMANCE GRAPHS

For additional performance graphs, please see the PMA5-83-2W+ datasheet.





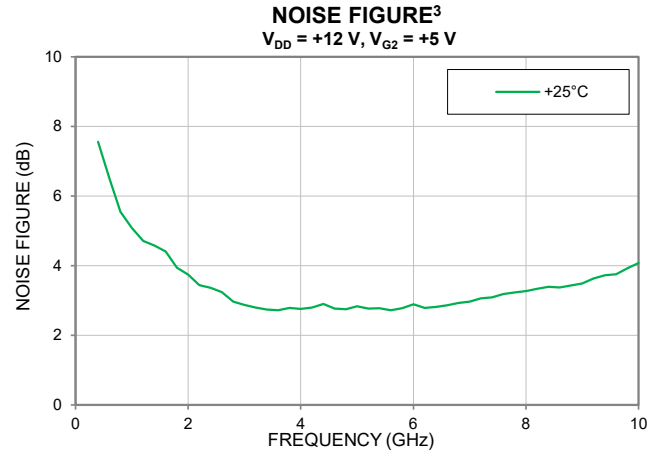
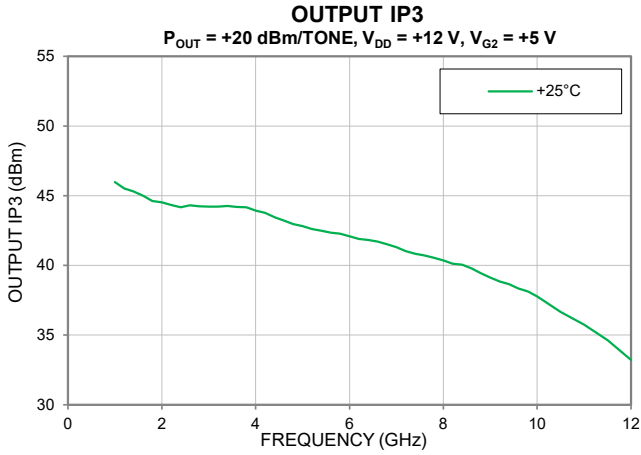
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TYPICAL PERFORMANCE GRAPHS



3. Noise Figure performance taken from packaged version of amplifier, PMA5-83-2W+.



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ABSOLUTE MAXIMUM RATINGS⁶

| Parameter | Ratings |
|---|-----------------|
| Operating Temperature ⁷ | -45°C to +85°C |
| Storage Temperature (for Die) ⁸ | -65°C to +150°C |
| Junction Temperature ⁹ | +175°C |
| Total Power Dissipation | 10 W |
| Input Power (CW), V _{DD} =+12 V | +31 dBm |
| DC Voltage at RF-OUT + V _{DD} | +16.5 V |
| Gate Voltage at V _{G1} | -0.2 V |
| Gate Voltage at V _{G2} | +7.5 V |
| DC Gate Current at V _{G1} (I _{G1}) | 4.5 mA |
| DC Gate Current at V _{G2} (I _{G2}) | 4.5 mA |

6. Permanent damage may occur if these limits are exceeded. Maximum ratings are not intended for continuous normal operation.

7. Bottom of Die

8. For die shipped in Gel-Pak see ENV-80 (limited by packaging)

9. Peak temperature on top of Die.

THERMAL RESISTANCE

| Parameter | Ratings |
|---|---------|
| Thermal Resistance (Θ _{jc}) ¹⁰ | 6°C/W |

10. Θ_{jc} = (Hot Spot Temperature on Die - Temperature at Ground Lead)/Dissipated Power

ESD RATING¹¹

| | Class | Voltage Range | Reference Standard |
|-----|-------|-------------------|-----------------------------|
| HBM | 1A | 250 V to < 500 V | ANSI/ESDA/JEDEC JS-001-2017 |
| CDM | C2 | 500 V to < 1000 V | JESD22-C101F |



ESD HANDLING PRECAUTION: This device is designed to be Class 1A for HBM. Static charges may easily produce potentials higher than this with improper handling and can discharge into DUT and damage it. As a preventive measure Industry standard ESD handling precautions should be used at all times to protect the device from ESD damage.

11. Tested in 5x5 mm 32-Lead QFN-Style Package





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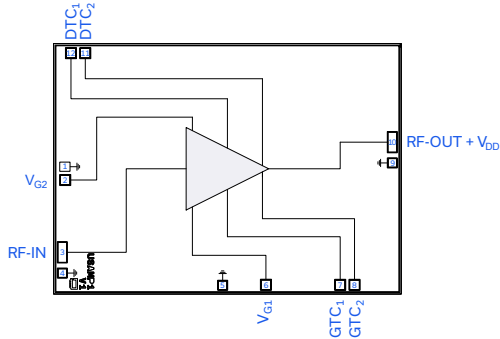


Figure 1. PMA5-83-2W-D+ Functional Diagram

PAD DESCRIPTION

| Function | Pad Number | Description (Refer to Figure 2) |
|--------------------------|-----------------------------|---|
| RF-IN | 3 | RF-IN Pad connects to RF Input port. |
| RF-OUT & V _{DD} | 10 | RF-OUT Pad connects to RF Output and V _{DD} port |
| V _{G1} | 6 | Gate 1 control voltage. |
| V _{G2} | 2 | Gate 2 control voltage. |
| DTC ₁ | 12 | Drain Low Frequency Termination Capacitor (AC GND) |
| DTC ₂ | 11 | Drain Low Frequency Termination Capacitor (AC GND) |
| GTC ₁ | 7 | Gate Low Frequency Termination Capacitor (AC GND) |
| GTC ₂ | 8 | Gate Low Frequency Termination Capacitor (AC GND) |
| GND | 1, 4, 5, 9, & Bottom of Die | Connects to ground. |

DIE OUTLINE: inches [mm], Typical

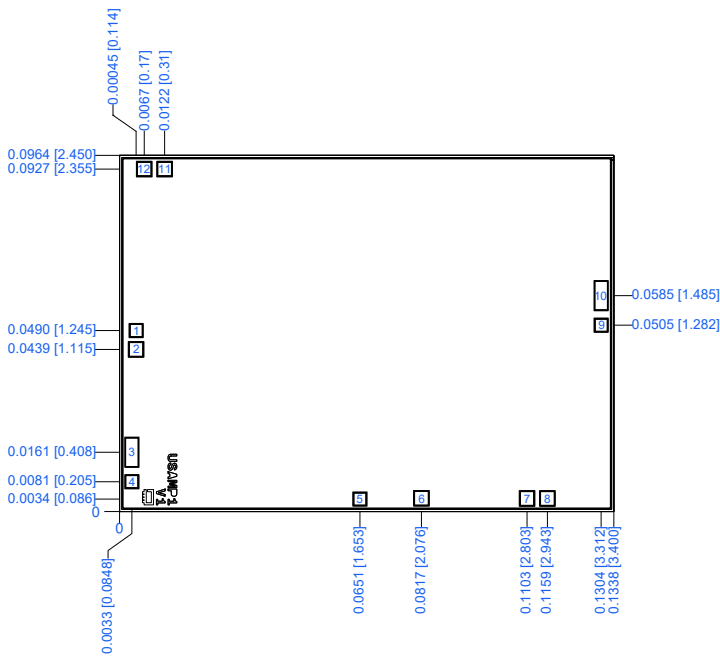


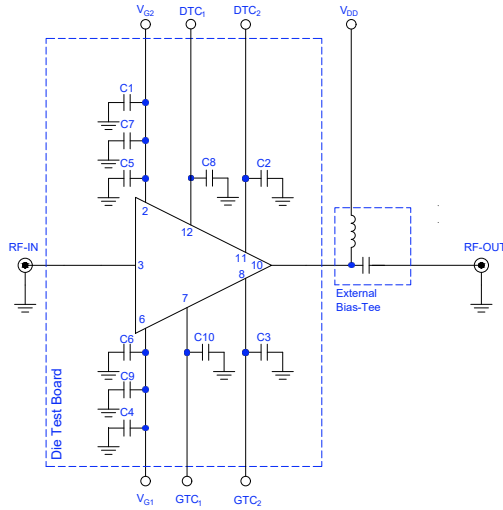
Figure 2. PMA5-83-2W-D+ Outline Drawing.

DIMENSIONS: inches [mm], Typical

| | |
|--------------------------------|------------------------------------|
| Die Size | 0.1338 x 0.0964 [3.400 x 2.450] |
| Die Thickness | 0.0040 [0.100] |
| Bond Pad Sizes: | |
| Pads 1, 4, 5, 9 | 0.0035 x 0.0035 [0.09 x 0.09] |
| Pads 2, 6, 7, 8, 11, 12 | 0.0039 x 0.0039 [0.1 x 0.1] |
| Pads 3, 10 | 0.0035 x 0.0079 [0.09 x 0.2] |
| Plating (Pads & Bottom of Die) | Gold |



CHARACTERIZATION BOARD



Electrical Parameters and Conditions

Gain, Return Loss, Output Power at 1 dB Compression (P1dB), Output IP3 (OIP3), and Noise Figure measured using N5247B PNA-X Microwave Network Analyzer. Device bias voltage V_{DD} supplied by external Bias-Tee.

Conditions:

Gain and Return Loss: P_{IN} = -25 dBm

Output IP3 (OIP3): Two tones, spaced 1 MHz apart, +20 dBm/tone at output.

Power ON/Power OFF Sequence

Caution: Permanent damage to the device will occur if the Power ON and Power OFF Sequences

Power ON:

1. Set V_{G1} = -2 V and Turn ON.
2. Set V_{G2} = +5 V and Turn ON.
3. Set V_{DD} = +12 V and Turn ON.
4. Increase V_{G1} to desired I_{bD}.
5. Turn ON RF Signal.

Power OFF:

1. Turn OFF RF Signal.
2. Decrease V_{G1} to -2 V.
3. Turn OFF V_{DD}.
4. Turn OFF V_{G2}.
5. Turn OFF V_{G1}.

Figure 3. Die Characterization Board

| Component | Value | Size | Part Number | Manufacturer |
|-----------------|---------|-------------|--------------------|-----------------|
| C1, C2, C3, C4 | 4.7 μF | 1206 | 12063C475KAT2A | AVX CORPORATION |
| C5 | 100 pF | 0.022x0.022 | MA4M3100 | MACOM |
| C6 | 100 pF | 0402 | GCM1555C1H101JA16D | MURATA |
| C7, C8, C9, C10 | 1000 pF | 0402 | GCM155R71H102KA37D | MURATA |



ASSEMBLY DIAGRAM

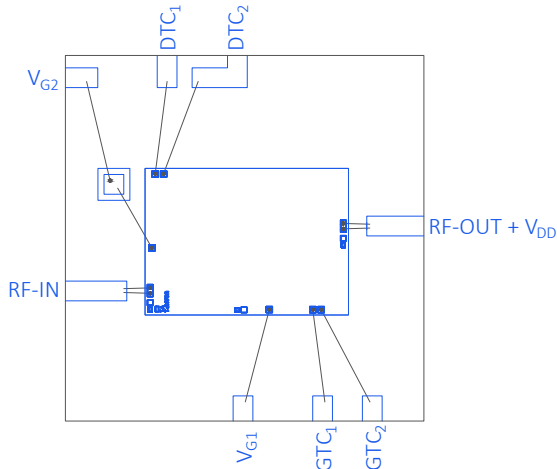



Figure 4. PMA5-83-2W-D+ Assembly Diagram

Refer to the table in Figure 2 for more details on the passive components.

- Bond wire diameter: 1 mil
- Bond wire lengths from Die Pad to PCB at RF-IN & RF-OUT ports: 22 ± 2 mils
- Typical Gap from Die edge to launcher edge: 10 mils
- PCB thickness and material: 8 mil RO4003C (Thickness: 1 oz copper on each side).

ASSEMBLY AND HANDLING PROCEDURE

1. Storage
Die should be stored in a dry nitrogen purged desiccator or equivalent.
2.  ESD Precautions
MMIC pHEMT amplifier die are susceptible to electrostatic and mechanical damage. Die are supplied in anti-static protected material, which should be opened only in clean room conditions at an appropriately grounded anti-static workstation.
3. Die Handling and Attachment
Devices require careful handling using tools appropriate for manipulating semiconductor chips. It is recommended to handle the chips along the edges with a custom designed collet. The surface of the chips have exposed air bridges and should not be touched with a vacuum collet, tweezers or fingers. The die mounting surface must be clean and flat. Using conductive silver-filled epoxy, apply sufficient adhesive to meet the required bond line thickness, fillet height and coverage around the total periphery of the device. The recommended epoxy is ATROX 800HT5 or equivalent. Parts should be cured in a nitrogen-filled atmosphere per manufacturer's recommended cure profile.
4. Wire Bonding
Openings in the surface passivation above the gold bond pads are provided to allow wire bonding to the die. Thermosonic bonding is recommended with minimized ultrasonic content. Bond force, time, ultrasonic power and temperature are all critical parameters. The suggested interconnect is pure gold, 1 mil diameter wire. Bonds are recommended to be made from the bond pads on the die to the package or substrate. All bond wire length and bond wire height should be kept as short as possible, unless specified by design, to minimize performance degradation due to undesirable series inductance.



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ADDITIONAL DETAILED INFORMATION IS AVAILABLE ON OUR DASH BOARD [CLICK HERE](#)

| | | | | | | | | | |
|---|---|-------------------|-----------|---------------------------|----------------|---|----------------|-------------------------|----------------|
| Performance Data & Graphs | Data Graphs S-Parameter (S2P Files) Data Set (.zip file) | | | | | | | | |
| Case Style | Die | | | | | | | | |
| RoHS Status | Compliant | | | | | | | | |
| Die Ordering and Packaging Information | <table border="0"> <tr> <td>Quantity, Package</td> <td>Model No.</td> </tr> <tr> <td>Gel - Pak: 5, 10, 50 KGD*</td> <td>PMA5-83-2W-DG+</td> </tr> <tr> <td>Medium[†], Partial wafer: KGD*<300</td> <td>PMA5-83-2W-DP+</td> </tr> <tr> <td>Full wafer[†]</td> <td>PMA5-83-2W-DF+</td> </tr> </table> [†] Available upon request contact sales representative. Refer to AN-60-067 | Quantity, Package | Model No. | Gel - Pak: 5, 10, 50 KGD* | PMA5-83-2W-DG+ | Medium [†] , Partial wafer: KGD*<300 | PMA5-83-2W-DP+ | Full wafer [†] | PMA5-83-2W-DF+ |
| Quantity, Package | Model No. | | | | | | | | |
| Gel - Pak: 5, 10, 50 KGD* | PMA5-83-2W-DG+ | | | | | | | | |
| Medium [†] , Partial wafer: KGD*<300 | PMA5-83-2W-DP+ | | | | | | | | |
| Full wafer [†] | PMA5-83-2W-DF+ | | | | | | | | |
| Die Marking | USAMP1 V1 | | | | | | | | |
| Environmental Ratings | ENV80 | | | | | | | | |

*Known Good Die ("KGD") means that the die in question have been subjected to Mini-Circuits DC test performance criteria and measurement instructions and that the parametric data of such die fall within a predefined range. While DC testing is not definitive, it does provide a higher degree of confidence that die are capable of meeting typical RF electrical parameters specified by Mini-Circuits.

Notes

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